

## 05N10-VB Datasheet N-Channel 100-V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>(BR)DSS</sub> (V)	$r_{DS(on)}(\Omega)$	I <sub>D</sub> (A)				
100	0.009 at V <sub>GS</sub> = 10 V	65				

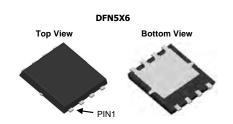
#### **FEATURES**

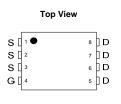
- Trench Power MOSFET
- 175 °C Junction Temperature
- Low Thermal Resistance Package
- 100 % R<sub>g</sub> Tested

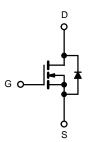


#### **APPLICATIONS**

• Isolated DC/DC Converters







N-Channel MOSFET

ABSOLUTE MAXIMUM RATING	<b>S</b> (T <sub>A</sub> = 25 °C, u	nless other	wise noted)		
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		$V_{DS}$	100	V	
Gate-source voltage		$V_{GS}$	± 20	v	
	T <sub>C</sub> = 25 °C		65		
O-ations and design and (T. 150 °C)	T <sub>C</sub> = 70 °C	† .	60		
Continuous drain current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	l <sub>D</sub>	20 b, c		
	T <sub>A</sub> = 70 °C	1	18.5 <sup>b, c</sup>		
Pulsed drain current (t = 100 µs)		I <sub>DM</sub>	180	A	
Continuous source-drain diode current	T <sub>C</sub> = 25 °C		60		
	T <sub>A</sub> = 25 °C	ls ls	4.8 b, c		
Single pulse avalanche current		I <sub>AS</sub>	30	7	
Single pulse avalanche energy	L = 0.1 mH	E <sub>AS</sub>	40	mJ	
	T <sub>C</sub> = 25 °C		80		
Maximum naugudiacination	T <sub>C</sub> = 70 °C	Б	50	w	
Maximum power dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	5 b, c	VV	
	T <sub>A</sub> = 70 °C		3.2 <sup>b, c</sup>		
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Soldering recommendations (peak temperature) <sup>c</sup>			260		

THERMAL RESISTANCE RATINGS							
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum junction-to-ambient b	t ≤ 10 s	$R_{thJA}$	20	25	°C/W		
Maximum junction-to-case (drain)	Steady state	$R_{thJC}$	1.6	2	J 6/W		

- a. Package limitedb. Surface mounted on 1" x 1" FR4 board

服务热线:400-655-8788

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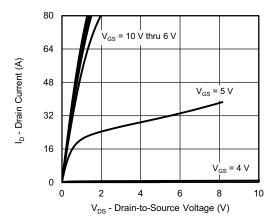
SPECIFICATIONS (T <sub>J</sub> = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static					•		
Drain-source breakdown voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100	-	-	V	
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 10 mA	-	81	-	\//00	
V <sub>GS(th)</sub> temperature coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA	-	-7.5	-	mV/°C	
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3	-	5	V	
Gate-source leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	100	nA	
Zana sata walta sa dualia a wasat		V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V	-	-	1	μА	
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 70 °C	-	-	15		
On-state drain current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	40	-	-	Α	
Due:	Б	V <sub>GS</sub> =10 V, I <sub>D</sub> = 10 A	-	0.009	-		
Drain-source on-state resistance a	R <sub>DS(on)</sub>	$V_{GS} = 7.5 \text{ V}, I_D = 10 \text{ A}$	-	0.012	-	Ω	
Forward transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 10 A	-	46	-	S	
Dynamic <sup>b</sup>					•		
Input capacitance	C <sub>iss</sub>		-	3970	-		
Output capacitance	C <sub>oss</sub>	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	132	-	рF	
Reverse transfer capacitance	C <sub>rss</sub>		-	11.2	-		
	$Q_g$	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$	-	20	-	nC	
Total gate charge			-	15	-		
Gate-source charge	$Q_{gs}$	$V_{DS} = 50 \text{ V}, V_{GS} = 7.5 \text{ V}, I_D = 10 \text{ A}$	-	6.45	-		
Gate-drain charge	Q <sub>gd</sub>		-	3.5	-		
Output charge	Q <sub>oss</sub>	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$	-	22	-		
Gate resistance	$R_g$	f = 1 MHz	0.2	0.76	1.4	Ω	
Turn-on delay time	t <sub>d(on)</sub>		-	12	24		
Rise time	t <sub>r</sub>	$V_{DD} = 50 \text{ V}, R_L = 5 \Omega, I_D \cong 10 \text{ A},$	-	5	10	1	
Turn-off delay time	t <sub>d(off)</sub>	$V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	19	38	1	
Fall time	t <sub>f</sub>		-	5	10	1	
Turn-on delay time	t <sub>d(on)</sub>		-	15	30	ns	
Rise time	t <sub>r</sub>	$V_{DD} = 50 \text{ V}, R_L = 5 \Omega, I_D \cong 10 \text{ A},$	-	6	12		
Turn-off delay time	t <sub>d(off)</sub>	$V_{GEN} = 7.5 \text{ V}, R_g = 1 \Omega$	-	19	38		
Fall time	t <sub>f</sub>		-	5	10	1	
Drain-Source Body Diode Characteristi	cs						
Continuous source-drain diode current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	60	_	
Pulse diode forward current	I <sub>SM</sub>		-	-	80	A	
Body diode voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A, V <sub>GS</sub> = 0 V	-	0.78	1.1	V	
Body diode reverse recovery time	t <sub>rr</sub>		-	43	86	ns	
Body diode reverse recovery charge	Q <sub>rr</sub>		-	72	144	nC	
Reverse recovery fall time	t <sub>a</sub>	$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	-	33	-		
Reverse recovery rise time	t <sub>b</sub>		-	10	-	ns	

#### Notes

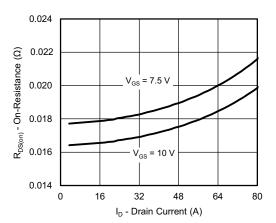
- a. Pulse test; pulse width  $\leq 300~\mu s,\,duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

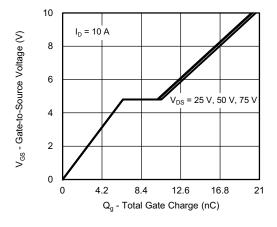




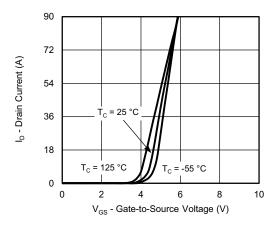
#### **Output Characteristics**



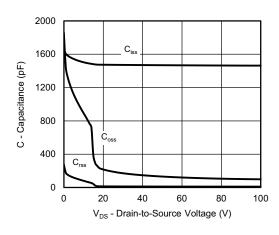
On-Resistance vs. Drain Current and Gate Voltage



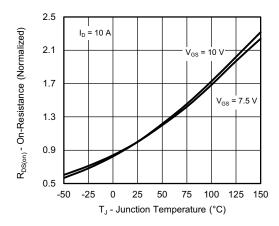
**Gate Charge** 



**Transfer Characteristics** 

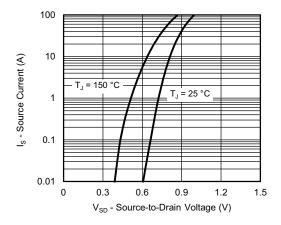


Capacitance

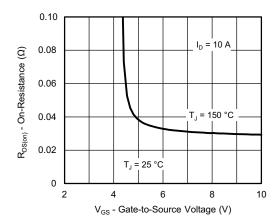


On-Resistance vs. Junction Temperature

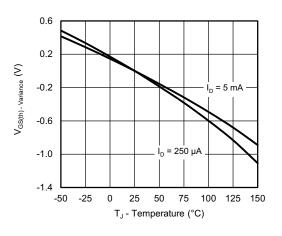




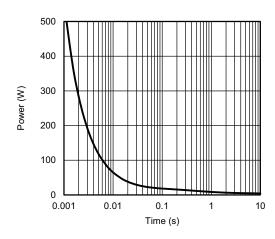
Source-Drain Diode Forward Voltage



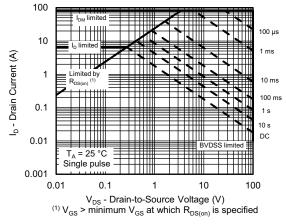
On-Resistance vs. Gate-to-Source Voltage



**Threshold Voltage** 

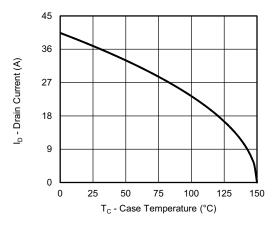


Single Pulse Power, Junction-to-Ambient



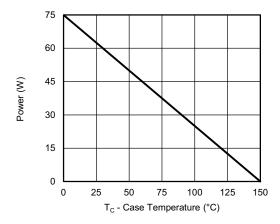
Safe Operating Area, Junction-to-Ambient

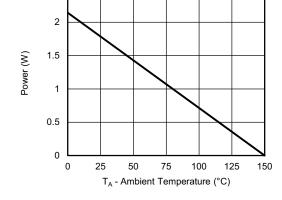




#### Current Derating <sup>a</sup>

2.5





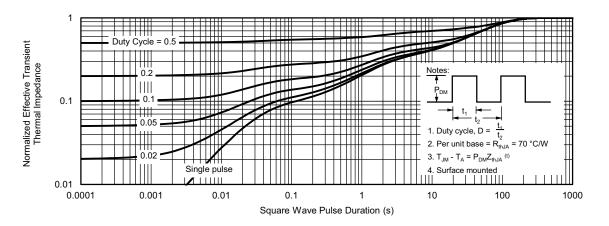
Power, Junction-to-Case

Power, Junction-to-Ambient

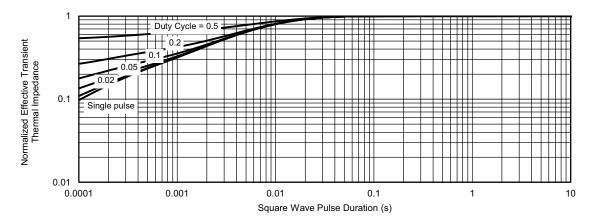
#### Note

a. The power dissipation  $P_D$  is based on  $T_J$  max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





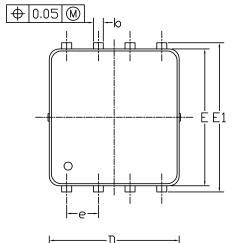
#### Normalized Thermal Transient Impedance, Junction-to-Ambient

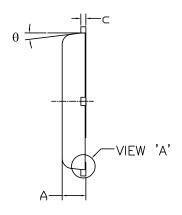


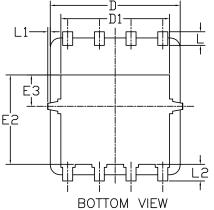
Normalized Thermal Transient Impedance, Junction-to-Case

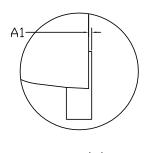


DFN5x6\_8L\_EP1\_P PACKAGE OUTLIN



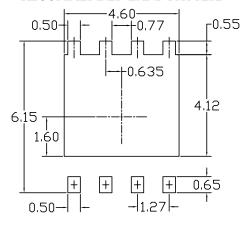






<u>VIEW 'A'</u> (SCALE 5:1)

#### RECOMMENDED LAND PATTERN



SYMBOLS DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES				
SYMBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
A	0.85	0. 95	1.00	0.033	0.037	0.039	
Al	0.00		0.05	0.000		0.002	
b	0.30	0.40	0.50	0.012	0.016	0.020	
c	0. 15	0. 20	0. 25	0.006	0.008	0.010	
D	5. 10	5. 20	5. 30	0. 201	0. 205	0. 209	
D1	4. 25	4. 35	4. 45	0. 167	0.171	0. 175	
Е	5. 45	5. 55	5. 65	0. 215	0.219	0. 222	
E1	5. 95	6.05	6. 15	0. 234	0. 238	0. 242	
E2	3. 525	3.625	3. 725	0.139	0. 143	0. 147	
E3	1. 175	1.275	1.375	0.046	0.050	0.054	
e	1. 27 BSC			0.050 BSC			
L	0.45	0. 55	0.65	0.018	0.022	0.026	
L1	0		0. 15	0		0.006	
L2	0.68 REF			0.027 REF			
θ	0°		10°	0°		10°	

#### **NOTE**

- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.
  MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

UNIT: mm



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